TEC-QEC Final Presentation days

Thursday, 29 June 2023

Session 4: Radiation Test Results - ESTEC - Tennis Hall (16:10 - 16:50)

-Conveners: Viyas Gupta

| time [id] title | presenter | |
|---|---|--|
| 16:10 [17] RACOCO | KUHNHENN, Jochen STEFFENS, Michael HOEFFGEN, Stefan | |
| 16:30 [21] Test Results on SDRAM IS42S86400B-7TLI | GLORIEUX, Maximilien | |

Friday, 30 June 2023

Session 4: Radiation Test Results - ESTEC - Tennis Hall (09:30 - 12:00)

| time [id] title | presenter |
|--|--|
| 09:30 [5] TID testing of statistically large quantitites of COTS parts | SHARP, Richard |
| 09:50 [23] SEE tests on power Schottky Diodes | ROUSSET, Alexandre GUILLERMIN, Jérémy |
| 10:10 Coffee Break | |
| 10:40 [4] Heavy Ion SEE Testing of Microsemi RTG4 flash based FPGA | SHARP, Richard |
| 11:00 [10] Heavy ion failure rate computation based on sensitive volume characterization in GaN/AlGaN FETs | MORAND, Sébastien |